Search Notes

Application/Contro	I No. Applica Reexam	nt(s)/Patent under ination
10/749,045	CHEN	ET AL.
Examiner	Art Unit	
Mathieu D. Vargot	1732	

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SEARCHED				
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264	328.7		•	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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